Notice of References Cited Application/Control No. 10/585,067 Examiner NICOLE M. BUIE-HATCHER Applicant(s)/Patent Under Reexamination TANAKA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-5,444,116	08-1995	Amin et al.	524/495	
	В	US-				
	C	US-				
	D	US-				
	Е	US-				
	F	US-				
	G	US-				
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.